

Notice of References Cited

Application/Control No.

09/929,995

Applicant(s)/Patent Under
Reexamination
TERNULLO ET AL.

Examiner

Sargon N. Nano

Art Unit

2157

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,587,835	07-2003	Treyz et al.	705/14
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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